



Seminar on Physics of Thin Films

SP-STM & MExFM

Jonas Kell – jonas.kell@student.uni-augsburg.de

Augsburg, 08.12.2022

Outline: Spin-Polarized-Scanning-Tunneling-Microscope

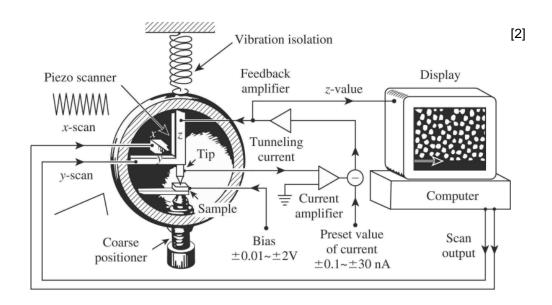
- 1 General Functionality & Construction
- 2 Spin Resolved/Polarized STM (SP-STM)
- 3 Experiments & Applications
- 4 Outlook: Magnetic Exchange Force Microscopy (MExFM)
- 5 Summary and Conclusion

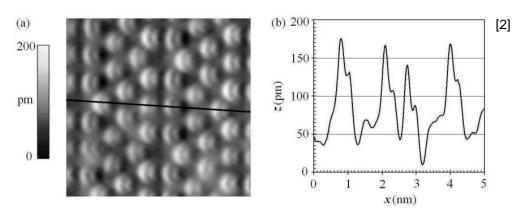


Construction & Current Feedback Mechanism

General Functionality & Construction

- Piezo electric crystals allow for very fine control
- Distance sample ↔ tip < 1nm
- Overlapping electron clouds allow for tunneling current to flow between tip/sample
 - Direction reversable, depending on bias voltage sign
- Feedback circuit keeps the perceived tip ↔ sample distance constant
- Combination with different control signals produces different scanning modes
 - A-Scan (dot, often time resolved)
 - B-Scan (line)
 - C-Scan (surface)



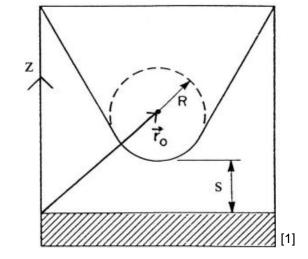




Mathematics of the Tunneling Process

General Functionality & Construction

- The tunneling current depends:
 - On the "local density of states" (LDOS, here n_s)
 - The bias voltage U
 - The distance to the sample S
 - The exponential dependency is key to the high resolution capability



$$I = \frac{2\pi e}{\hbar} U \sum_{\mu,\nu} |M_{\mu\nu}|^2 \delta(E_{\nu} - E_F) \delta(E_{\nu} - E_F)$$

$$M_{\mu\nu} = \frac{-\hbar^2}{2m} \int dS (\Psi_{\mu}^* \nabla \Psi_{\nu} - \Psi_{\nu} \nabla \Psi_{\mu}^*) \qquad n_S(E_F, \vec{r}_0) = \sum_{\nu} |\Psi_{\nu}(\vec{r}_0)|^2 \delta(E_{\nu} - E_F)$$

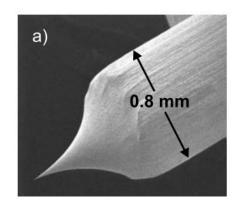
$$\Psi_{\mu} = \frac{1}{R} e^{-\kappa R} \qquad I \propto \exp\left(-2\kappa s\right)$$

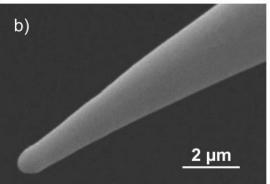


Environment & Generating Tips

General Functionality & Construction

- Temperature range generally in the region of mK to some K
 - Too high temperatures cause thermal fluctuations to overshadow measured effects
- Measuring at atom-scale resolution generally requires ultra-high-vacuum (UHV) setups
 - Kinetic energy of gas molecules causes noise through collisions
 - Tips get contaminated with oxides
- Tip preparation
 - Generally performed *in situ* to avoid contaminations
 - Pulling procedures
 - Electrochemical etching methods
 - Cleanup through electron/ion bombardment





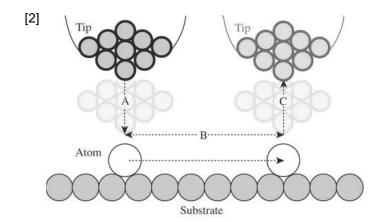
[1]



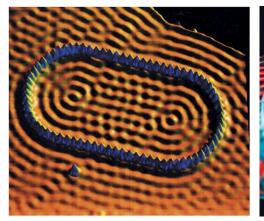
Example: Manipulation of individual atoms

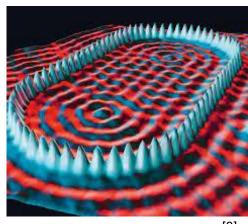
General Functionality & Construction

- Active manipulation of the sample on the per-atom basis
- Constructive process to "drag" atoms into desired locations
- Multiple applications
 - Data storage
 - Sample preparation (for other measurements)
 - Validation of theorized wavefunction behavior

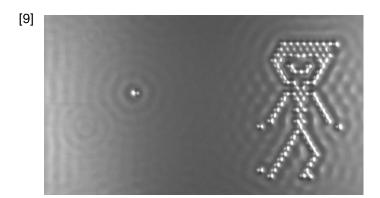


"Quantum Corrals"





[8]





[1] [2] [8]

Theory of the Spin Resolved STM

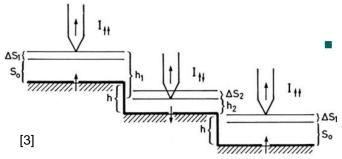
Spin Resolved/Polarized STM (SP-STM)

- The model for a spin-dependent ferromagnet-ferromagnet tunnel junction is applied
- The local densities of states for tip and sample

$$- n_t = n_t^{\uparrow} + n_t^{\downarrow}, \quad n_s = n_s^{\uparrow} + n_s^{\downarrow}$$

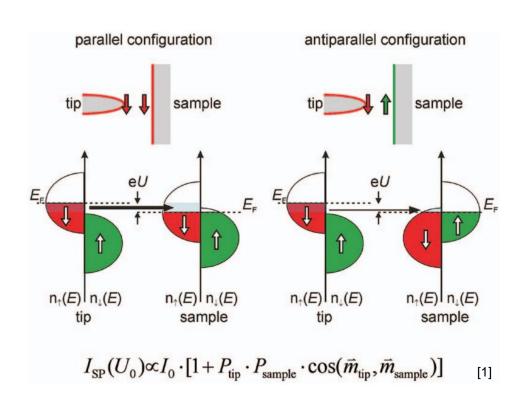
$$- P_t = m_t/n_t, P_s = m_s/n_s$$

 First time experimentally confirmed for stepped antiferromagnetic coordinated, stepped chromium surface



Sample composition

- Cr(001)
- Steps non-magnetic: 0.144nm
- Steps magnetic: 0.12nm/0.16nm

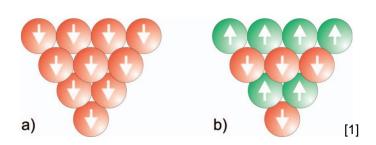


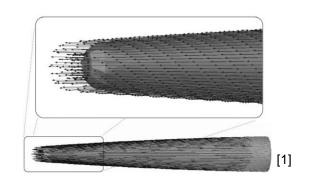


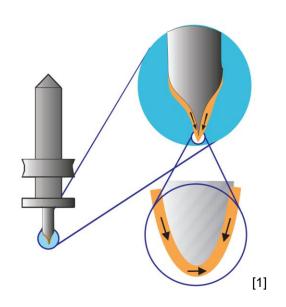
Tip ↔ Sample Material Combinations

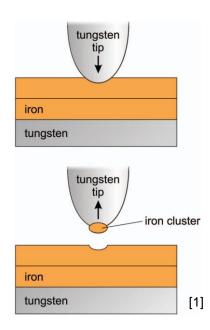
Spin Resolved/Polarized STM (SP-STM)

- Only the tip or the material are magnetic
 - Equivalent to regular STM, no Spin resolved measurement
- Tip/sample magnetized by optical pumping
- Tip from magnetic material
 - Tip from bulk magnetic material
 - Non-magnetic tips coated with magnetic thinfilms
 - Easy to handle, versatile and precise
 - Magnetic clusters bonded to the tip
 - Very easy tip generation process











Modes of Operation

Spin Resolved/Polarized STM (SP-STM)

Constant-current

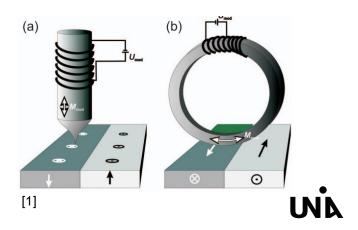
- Default imaging mode of STM
- Feedback circuit makes sure, that the tunneling current is kept constant
- The smallest magnetic superstructure will be imaged with SP-STM, not necessarily the atomic structure

SR-spectroscopic

- Aims to provide separation between topographic structure and electronic structure
- Probing bias voltage is modulated
- Extracts energy dependency of the local electron density of states (LDOS)
- Need to be measured at fixed tip ↔ sample distance (either stationary or secondary ample-and-hold amplifier)

Modulated tip

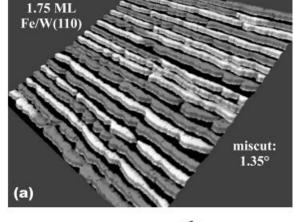
- Aims to provide separation between electronic structure and magnetic structure
- Magnetization of the tip is modulated periodically
- Additionally requires bias voltage modulation and tip distance modulation

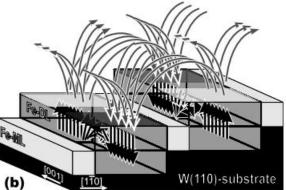


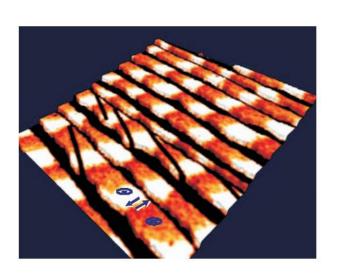
Nanostripes on stepped Surfaces

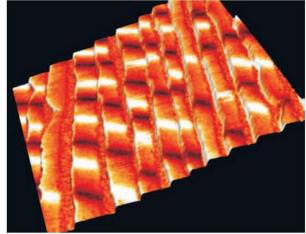
Experiments & Applications

- Nanostripes get formed when material is deposited on stepped substrate
- Magnetic effects may emerge that depend on the topology
 - Influence of the width?
 - Influence of the height?
 - Influence or the distance between stripes?









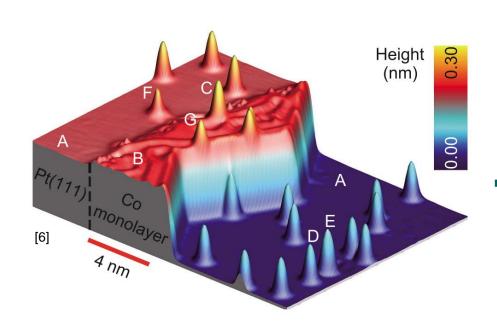
- Sample composition
 - W(110)
 - Fe monolayer
 - Fe doublelayer
 - Left, stripe-width > 10nm, right < 10nm



Measurements on single Adatoms

Experiments & Applications

- Same tip to measure Ir as well as Co locations
 - Spin polarization of tip can be determined
 - Makes arguing about the spin relation surface ↔ adatom possible
- Spin polarization effect of large magnitude when looking at a Co-dimer



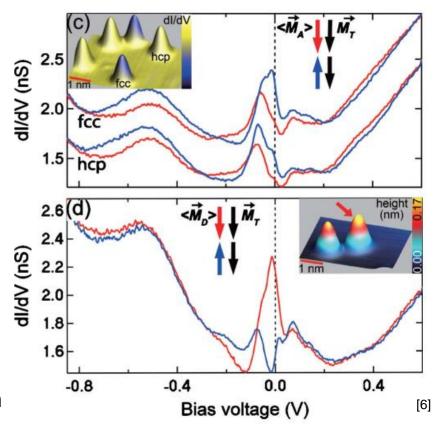
Sample composition

- Pt(111)

Co monolayer B

C&D Co adatoms

 Co dimer Ε

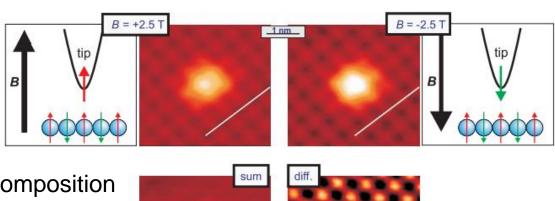




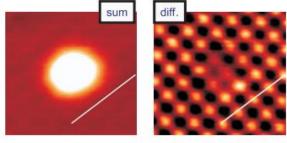
Antiferromagnetic Arrangements

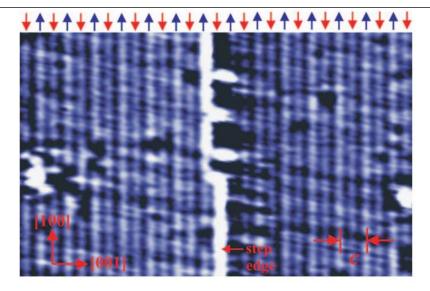
Experiments & Applications

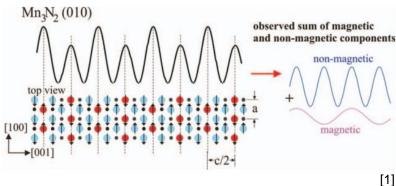
- Averaging measuring procedures do not allow resolving antiferromagnetic superstructures
 - If magnetic unit cell is smaller than resolution, the magnetic moment is averaged and vanishes
- Topology can be affected by magnetic and non-magnetic contributions



- Sample composition
 - W(001)
 - Fe Monolayer







- Sample composition
 - $-Mn_3N_2(010)$



[1]

Time Resolved Experiments

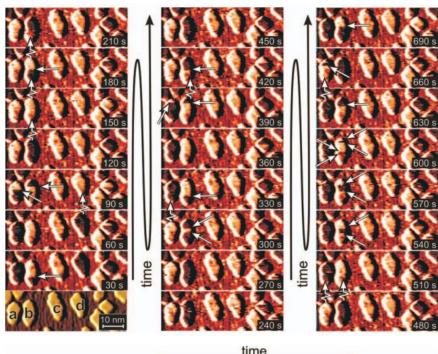
Experiments & Applications

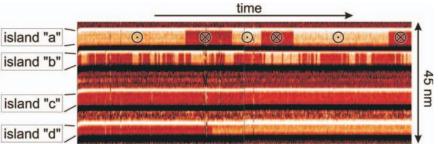
- SP-STM does not only image in real-space, but consequently also in the real-time domain
- Time resolution depends on imaging mode and spacial resolution
- Switching events most of the time thermally induced
 - May also be a result of the probe's influence or an external magnetic field

- Sample composition
 - Mo(110)
 - Fe islands (area < 40nm²)
- Antiferromagnetic tip required

[1][7]

 Magnetic stray field of a ferromagnetic tip would influence switching behavior



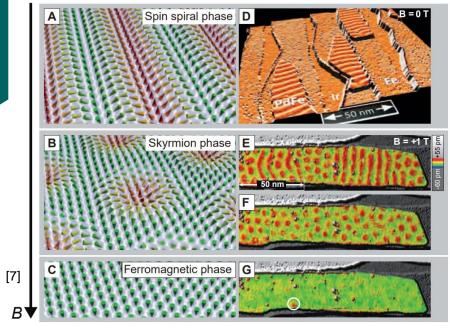


[1]



Magnetic RAM through Skyrmion Manipulation

Experiments & Applications

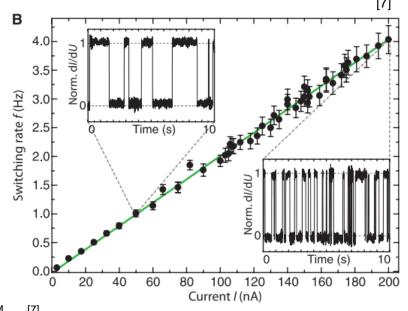


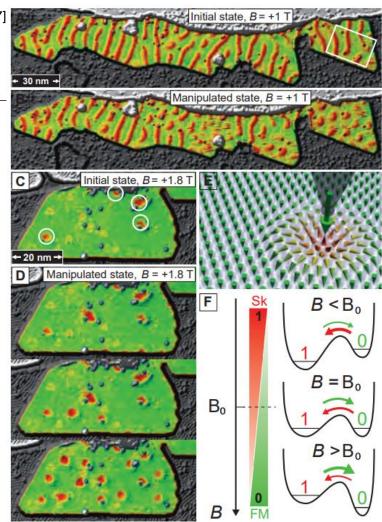
- High temperature (T~8 K)
 - Thermal reordering possible
- Low temperature (T~4.2 K)
 - Only induced reordering possible

T~8 K

T~4.2 K

- Sample composition
 - Ir(111)
 - PdFe Bilayer





Switching rate

- Depends linearily on the tunnel current
- Also voltage dependent (not shown)



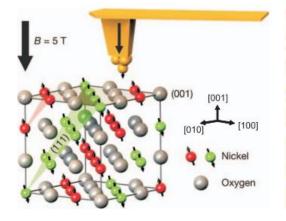
Spin Resolved Microscopy for Insulators?

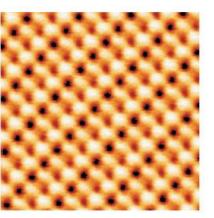
Outlook: Magnetic Exchange Force Microscopy (MExFM)

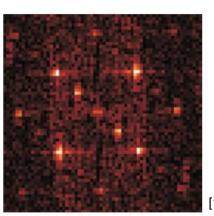
- No conductive samples needed
 - Electromagnetic exchange forces are used to deflect a cantilever that carries the probe tip
- Modes of operation
 - "Contact-mode": static mode of operation,
 - "Tapping-mode": dynamic mode of operation,
 - "Non-contact-mode": dynamic mode of operation,

tip is dragged along the surface cantilever is exited to oscillate and bring the tip very close to the sample oscillating of the tip near resonant frequency, interaction forces change the resonant frequency

Magnetized tips may be used to resolve spin dependent interaction forces







1]



[1] [3] [4]

Head-to-head Comparison: MExFM ↔ SP-STM

Outlook: Magnetic Exchange Force Microscopy (MExFM)

Sample Conductivity

SP-STM: requires electrically conductive samples

MExFM: both conductive and non-conductive samples

Temperature range

SP-STM: already applied in the range from 300mK to 350K

MExFM: atomic resolution so far only for low temperature experiments

UHV environment

Typically needed, but both can also be performed in liquid (→ immobilizing molecules & combing)

Supports probing with external magnetic fields

High strength fields applicable to both methods

Precision and complexity

- Comparable in terms of cost & effort
- STM is often said to have better resolution however both can achieve atom-scale-resolution
- SP-STM more applications in research (spin based), while AFM more widespread in the industry



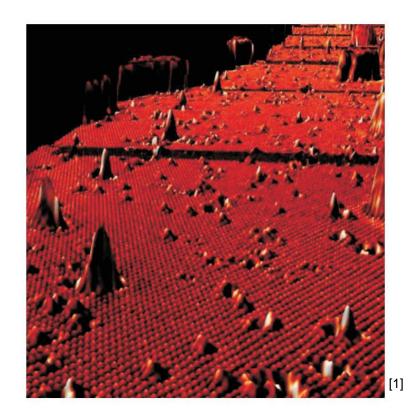
Final Overview

Summary and Conclusion

- Methods allow for probing on atomic scale
 - Measurements are performed in real-space, contrary to most atom-scale measurement methods
- Magnetic moment can be resolved locally
 - Avoids missing substructures with on average neutral magnetic moments
- Possible for metals, as well as insulators
 - SP-STM for metals
 - MExFM for insulators
- Comparably high time-resolution
 - Reducing resolution allows to study the changes of magnetic moments close to real time
- Active manipulation of sample possible (on measurement-scale)
 - Construct custom test environments for wavefunctions
 - Manipulate/create individual molecules for chemical research



Thank you for your kind attention





Jonas Kell
Augsburg University
jonas.kell@student.uni-augsburg.de



References

Text and Image References

- [1] Spin mapping at the nanoscale and atomic scale (Wiesendanger 2009)
- [2] Introduction to Scanning Tunneling Microscopy (Chen 2007)
- [3] Observation of vacuum tunneling of spin-polarized electrons with the scanning tunneling microscope (Wiesendanger 1990)
- [4] Atomic resolution in scanning force microscopy: Concepts, requirements, contrast mechanisms, and image interpretation (Schwarz 2000)
- [5] Spin polarization of platinum (111) induced by the proximity to cobalt nanostripes (Meier 2011)
- [6] Inversion of spin polarization above individual magnetic adatoms (Zhou 2010)
- [7] Writing and Deleting Single Magnetic Skyrmions (Romming 2013)
- [8] Confinement of Electrons to Quantum Corrals on a Metal Surface (Crommie 1993)
- [9] A Boy And His Atom: The World's Smallest Movie (IBM 2013)

